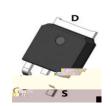


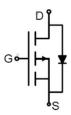
# SMT002P15C1

## Main Product Characteristics:

V <sub>DSS</sub>	-20V				
R <sub>DS</sub> (on)	15m (typ.)				
ID	-17A				



TO-252



Schematic Diagram

#### **Features and Benefits:**

- Advanced MOSFET process technology
- Special designed for PWM, load switching and general purpose applications
- Ultra low on-resistance with low gate charge
- Fast switching and reverse body recovery
- 150 operating temperature



#### **Description:**

It utilizes the latest processing techniques to achieve the high cell density and reduces the on-resistance with high repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in power switching application and a wide variety of other applications.

#### **Absolute Max Rating:**

Symbol Parameter		Max.	Units	
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	-17		
I <sub>D</sub> @ T <sub>C</sub> = 100°C	°C Continuous Drain Current, V <sub>GS</sub> @ 10V		A	
Ідм	Pulsed Drain Current	-68	1	
$P_{D} @T_{C} = 25^{\circ}C$	$P_D @T_C = 25^{\circ}C$ Power Dissipation		W	
V <sub>DS</sub>	Drain-Source Voltage	-20	V	
V <sub>GS</sub> Gate-to-Source Voltage		± 12	V	
Eas	Single Pulse Avalanche Energy @ L=0.5mH	42	mJ	
Tj Tstg	Operating Junction and Storage Temperature Range	-55 to +150	°C	

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## Thermal Resistance

Symbol	Characterizes	Тур.	Max.	Units
R <sub>JC</sub>	Junction-to-Case		12	/W

#### Electrical Characterizes @T<sub>A</sub>=25 unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source breakdown voltage	-20	—	—	V	$V_{GS} = 0V, I_D = -250 \mu A$
R <sub>DS(on)</sub>	Static Drain-to-Source on-resistance		15	20	m	V <sub>GS</sub> = -4.5V,I <sub>D</sub> = -15A
			19	25		V <sub>GS</sub> = -2.5V,I <sub>D</sub> = -10A
$V_{GS(th)}$	Gate threshold voltage	-0.4	—	-1	V	$V_{DS} = V_{GS}, I_D = -250 \mu A$
I <sub>DSS</sub>	Drain-to-Source leakage current	—	—	-1	μA	$V_{DS} = -20V, V_{GS} = 0V$
	Coto to Source forward lookage	—	—	100	– nA	V <sub>GS</sub> =12V
I <sub>GSS</sub>	Gate-to-Source forward leakage		—	-100		V <sub>GS</sub> = -12V
Ciss	Input capacitance		1330	—		V <sub>GS</sub> = 0V
Coss	Output capacitance		220	—	pF	V <sub>DS</sub> = -10V
C <sub>rss</sub>	Reverse transfer capacitance		175	—		f = 1MHz
Qg	Total gate charge		15	_		I <sub>D</sub> = -6A,
Q <sub>gs</sub>	Gate-to-Source charge		2	_	nC	V <sub>DS</sub> = -20V,
Q <sub>gd</sub>	Gate-to-Drain("Miller") charge		4.2	—		V <sub>GS</sub> = -4.5V
t <sub>d(on)</sub>	Turn-on delay time		10	—		
tr	Rise time	_	30	_		$V_{GS}$ = -4.5V, $V_{DS}$ = -10V,
t <sub>d(off)</sub>	Turn-Off delay time	_	25	_	ns	$R_{GEN}=2.5$ , $I_{D}=-12A$
t <sub>f</sub>	Fall time	_	8	_		

## **Source-Drain Ratings and Characteristics**

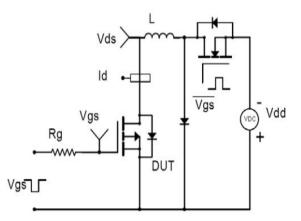
Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
ls	Continuous Source Current	_	_	-17	А	MOSFET symbol
	(Body Diode)					showing the Generation
I <sub>SM</sub>	Pulsed Source Current		—	-68	A	integral reverse
	(Body Diode)					p-n junction diode.
V <sub>SD</sub>	Diode Forward Voltage	_	_	-1.2	V	I <sub>S</sub> =-17A, V <sub>GS</sub> =0V



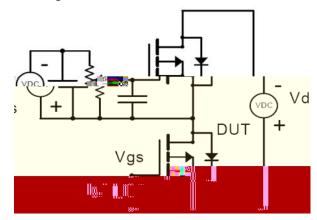
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## **Test Circuits and Waveforms**

#### EAS Test Circuit:



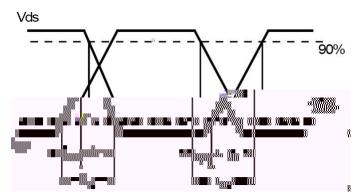
Gate Charge Test Circuit:



Switching Time Test Circuit:



Switching Waveforms:



#### Notes:

Calculated continuous current based on maximum allowable junction temperature.

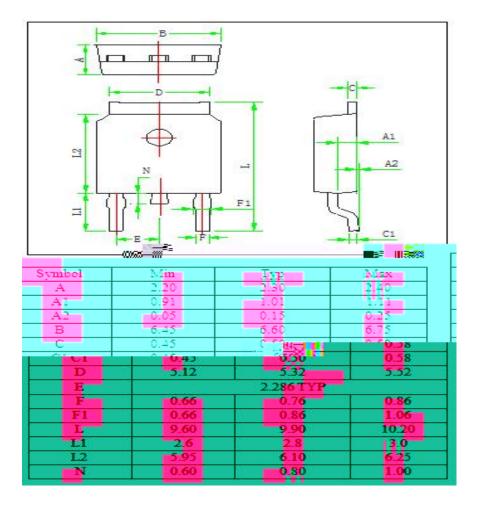
Repetitive rating; pulse width limited by max. junction temperature.

The power dissipation PD is based on max. junction temperature, using junction-to-case thermal resistance.



## SMT002P15C1

### **Mechanical Data**





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